

<b>Notice of References Cited</b>		Application/Control No. 10/579,066	Applicant(s)/Patent Under Reexamination KAMIJO ET AL.	
		Examiner MICHAEL M. BERNSHTEYN	Art Unit 1796	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,002,977	03-1991	Seko et al.	522/149
*	B	US-6,005,056	12-1999	Neis et al.	525/327.3
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N	JP 10253815 A	09-1998	Japan	FUJIWARA et al.	
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	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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